

Notice of References Cited

Application/Control No.

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Applicant(s)/Patent Under
Reexamination
SHIBAHARA, HIDEO

Examiner

Prasad R Akkapeddi

Art Unit

2871

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U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------------|----------------|
| | A | US-6,122,033 | 09-2000 | Mathew et al. | 349/155 |
| | B | US-6,067,144 | 05-2000 | Murouchi, Katsunori | 349/156 |
| | C | US-6,414,733 | 07-2002 | Ishikawa et al. | 349/110 |
| | D | US-5,739,888 | 04-1998 | Ogura et al. | 349/153 |
| | E | US-6,288,766 | 09-2001 | Mashiko et al. | 349/189 |
| | F | US-5,953,087 | 09-1999 | Hoyt, Clifford C. | 349/58 |
| | G | US-5,016,987 | 05-1991 | Smith, Jr., Willis H. | 349/153 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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